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Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,219	PHAM ET AL.
Examiner	Art Unit
John L. Goff	1733

SEARCHED						
Class	Subclass	Date	Examiner			
156	285,286, 307.1, 307.7	4/13/2005	JG			
244	131	4/13/2005	JG			
264	101,102	4/13/2005	JG			
264	571	4/13/2005	JG			
Above	UPDATED	8/16/2005	JG			
			1			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
DATE	EXMR		
8/16/2005	JG		
8/16/2005	JG		
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	DATE . 8/16/2005		